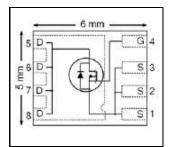




V <sub>DSS</sub>	30	٧
R <sub>DS(on)</sub> max (@ V <sub>GS</sub> = 10V)	1.4	mΩ
Qg (typical)	50	nC
Rg (typical)	1.3	Ω
I <sub>D</sub> (@T <sub>C (Bottom)</sub> = 25°C)	336	A





# **Applications**

- OR-ing MOSFET for 12V (typical) Bus in-Rush Current
- Battery Operated DC Motor Inverter MOSFET

#### **Features**

Low RDSon (<1.4 mΩ)	
Low Thermal Resistance to PCB (< 0.5°C/W)	
100% Rg tested	
Low Profile (< 0.9mm)	
Industry-Standard Pinout	results in
Compatible with Existing Surface Mount Techniques	$\Rightarrow$
RoHS Compliant Containing no Lead, no Bromide and no Halogen	
MSL1, Industrial Qualification	

#### **Benefits**

	Lower Conduction Losses
	Enable better Thermal Dissipation
	Increased Reliability
	Increased Power Density
า	Multi-Vendor Compatibility
	Easier Manufacturing
	Environmentally Friendlier
	Increased Reliability

Orderable Bort Number	Dookogo Type	Standard P	ack	Note
Orderable Part Number	Package Type	Form	Quantity	Note
IRFH5300TRPbF	PQFN 5mm x 6mm	Tape and Reel	4000	
IRFH5300TR2PbF	PQFN 5mm x 6mm	Tape and Reel	400	EOL notice #259

## **Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
V <sub>DS</sub> Drain-to-Source Voltage		30	V
$V_{GS}$	Gate-to-Source Voltage	± 20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ®	40	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V®	32	
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ®	336	Α
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ®	212	
I <sub>DM</sub>	Pulsed Drain Current ①	1344	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ®	3.6	14/
P <sub>D</sub> @T <sub>C(Bottom)</sub> = 25°C	Power Dissipation ④	250	W
	Linear Derating Factor ⑤	0.029	W/°C
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		°C

Notes ① through ⑥ are on page 9



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.1	1.4		V <sub>GS</sub> = 10V, I <sub>D</sub> = 50A ③
			1.7	2.1	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 50A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.35	1.8	2.35	V	\\ -\\   - 150\
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-6.2		mV/°C	$V_{DS} = V_{GS}$ , $I_D = 150 \mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			5.0		$V_{DS} = 24V, V_{GS} = 0V$
				150	μA	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nΛ	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
gfs	Forward Transconductance	190			S	$V_{DS} = 15V, I_{D} = 50A$
$Q_g$	Total Gate Charge		120		nC	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A$
$Q_g$	Total Gate Charge		50	75		
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		12			V <sub>DS</sub> = 15V
$Q_{gs2}$	Post-Vth Gate-to-Source Charge		6.5		nC	V <sub>GS</sub> = 4.5V
$Q_{gd}$	Gate-to-Drain Charge		16		lic	I <sub>D</sub> = 50A
$Q_godr$	Gate Charge Overdrive		16			See Fig. 17a & 17b
$Q_{sw}$	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		23			
Q <sub>oss</sub>	Output Charge		30		nC	$V_{DS} = 16V, V_{GS} = 0V$
$R_G$	Gate Resistance		1.3		Ω	
t <sub>d(on)</sub>	Turn-On Delay Time		26			$V_{DD} = 15V, V_{GS} = 4.5V$
t <sub>r</sub>	Rise Time		30			I <sub>D</sub> = 50A
$t_{d(off)}$	Turn-Off Delay Time		31		ns	$R_G=1.8\Omega$
t <sub>f</sub>	Fall Time		13			See Fig. 15
C <sub>iss</sub>	Input Capacitance		7200			$V_{GS} = 0V$
Coss	Output Capacitance		1360		pF	V <sub>DS</sub> = 15V
C <sub>rss</sub>	Reverse Transfer Capacitance		590			f = 1.0 MHz

## **Avalanche Characteristics**

	Parameter	Тур.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy ②		420	mJ
$I_{AR}$	Avalanche Current ①		50	Α

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			250		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			1344		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.0	V	$T_J = 25^{\circ}C$ , $I_S = 50A$ , $V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		34	51	ns	$T_J = 25$ °C, $I_F = 50$ A, $V_{DD} = 15$ V
$Q_{rr}$	Reverse Recovery Charge		68	100	nC	di/dt = 200A/µs ③

### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
R <sub>θJC</sub> (Bottom)	Junction-to-Case ④		0.5	
R <sub>θJC</sub> (Top)	Junction-to-Case ④		15	°C/W
$R_{\theta JA}$	Junction-to-Ambient ©		35	C/VV
R <sub>θJA</sub> (<10s)	Junction-to-Ambient ©		21	

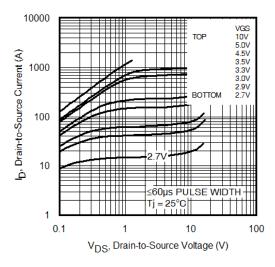


Fig 1. Typical Output Characteristics

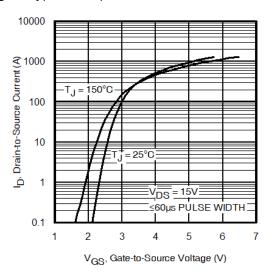


Fig 3. Typical Transfer Characteristics

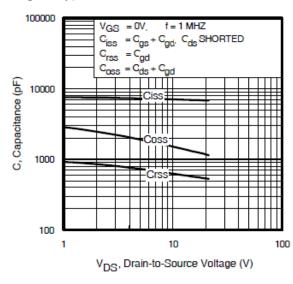


Fig 2. Typical Output Characteristics

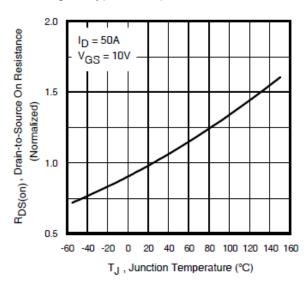


Fig 4. Normalized On-Resistance vs. Temperature

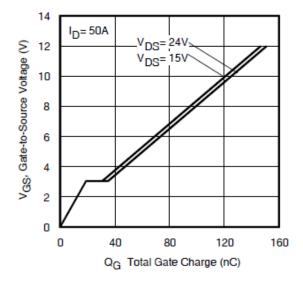
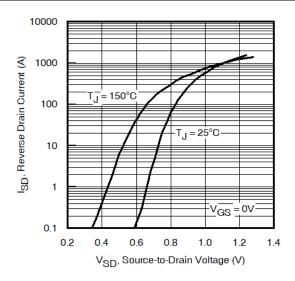


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

3



OPERATION IN THIS AREA LIMITED BY RDS (on) Drain-to-Source Current (A) 1000 100µsec 1msec 100 10 ڡٛ Tc = 25°C Tj = 150°C Single Pulse 0.1 0.1 10 100  $V_{DS}$ , Drain-to-Source Voltage (V)

10000

Fig 7. Typical Source-Drain Diode Forward Voltage

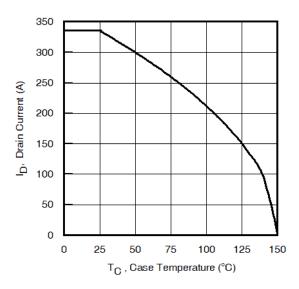


Fig 8. Maximum Safe Operating Area

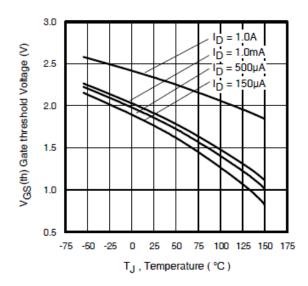


Fig 9. Maximum Drain Current vs. Case (Bottom) Temperature

Fig 10. Threshold Voltage vs. Temperature

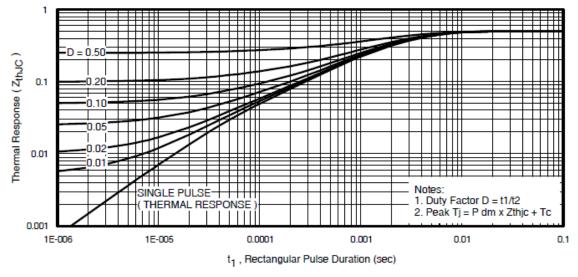
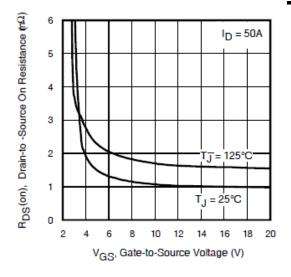


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case (Bottom)





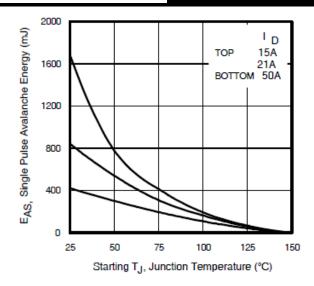


Fig 12. On-Resistance vs. Gate Voltage

Fig 13. Maximum Avalanche Energy vs. Drain Current

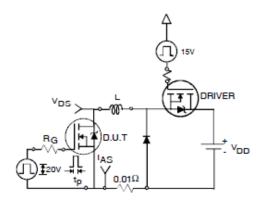


Fig 14a. Unclamped Inductive Test Circuit

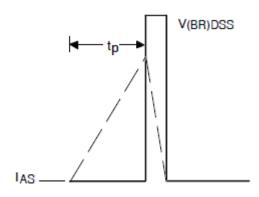


Fig 14b. Unclamped Inductive Waveforms

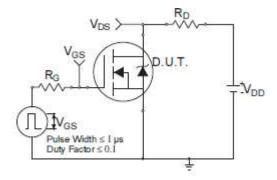


Fig 15a. Switching Time Test Circuit

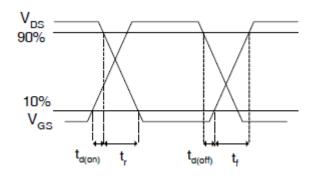


Fig 15b. Switching Time Waveforms



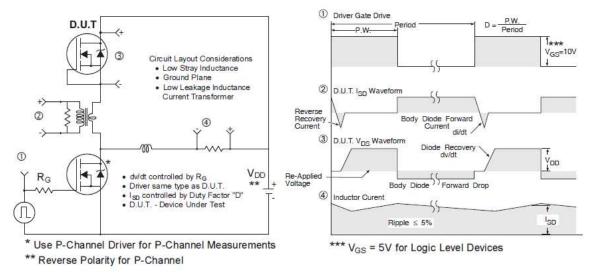
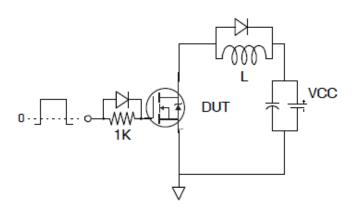
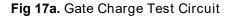


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs





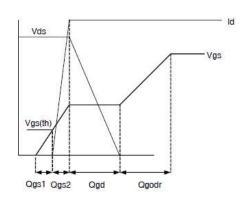
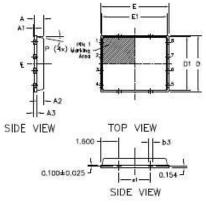


Fig 17b. Gate Charge Waveform



## PQFN 5x6 Outline "B" Package Details

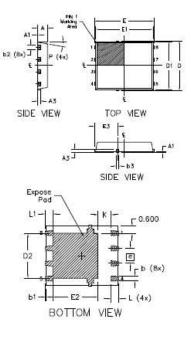


0.422 —	-	<del>  к</del>	
Tel	R2 —		0.395
D2 6	- - -		e
Expose _	— E4 —		b (8x)
	I— E2 − BOTTOM	g 88 88	-L (4×)

NID N	DIM MILLIMITERS		- 11	ICH
SYMBOL	MIN	MAX	MIN	MAX
A	0.800	0.900	0.0315	0.0543
A1	0.000	0.050	0.0000	0.0020
А3	0.20	0 REF	0.007	79 REF
b	0.350	0.470	0.0138	0.0185
b1	0.025	0.125	0.0010	0.0049
b2	0.210	0.410	0.0083	0.0161
b3	0.150	0.450	0.0059	0.0177
D	5.00	0 BSC	0.1969 BSC	
D1	4.75	0 BSC	0.1870 BSC	
D2	4.100	4.300	0.1614	0.1693
Е	6.00	0 BSC	0.2362 BS0	
E1	5.75	0 BSC	0.226	4 BSC
E2	3.380	3.780	0.1331	0.1488
е	e 1.270 REF 0.0500		00 REF	
e1	2.80	00 REF	0.11	02 REF
K	1.200	1.420	0.0472	0.0559
L	0.710	0.900	0.0280	0.0354
Р	0*	12"	0.	12*
R	0.200 REF		0.007	9 REF
R2	0.150	0.200	0.0059	0.0079

#### Note:

## PQFN 5x6 Outline "G" Package Details



DIM	MILLIM	ETERS	INCH		
SYMBOL	MIN.	MAX.	MIN.	MAX.	
Α	0.950	1.050	0.0374	0.0413	
A1	0.000	0.050	0.0000	0.0020	
A3	0.254	REF	0.0100	REF	
q	0.310	0.510	0.0122	0.0201	
b1	0.025	0.125	0.0010	0.0049	
b2	0.210	0.410	0.0083	0.0161	
Ь3	0.180	0.450	0.0071	0.0177	
D	5.150	BSC	0.2028 BSC		
D1	5.000	BSC	0.1969 BSC		
D2	3.700	3.900	0.1457	0.1535	
E	6,150	BSC	0.2421 BSC		
E1	6.000	BSC	0.2362 BSC		
E2	3.560	3.760	0.1402	0.1488	
E3	2.270	2.470	0.0894	0.0972	
e	1.27	REF	0.050	REF	
K	0.830	1,400	0.0327	0.0551	
L	0.510	0.710	0.0201	0.0280	
L1	0.510	0.710	0.0201	0.0280	
Р	10 deg	12 deg	0 deg	12 deg	

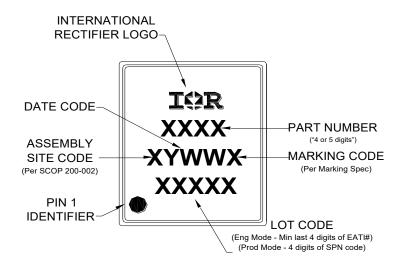
MULTIPERS

- 3. Captanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <a href="http://www.irf.com/technical-info/appnotes/an-1136.pdf">http://www.irf.com/technical-info/appnotes/an-1136.pdf</a>
For more information on package inspection techniques, please refer to application note AN-1154: <a href="http://www.irf.com/technical-info/appnotes/an-1154.pdf">http://www.irf.com/technical-info/appnotes/an-1154.pdf</a>

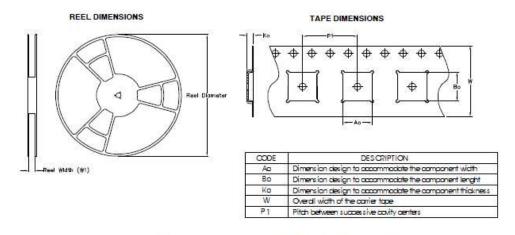


#### **PQFN 5x6 Part Marking**

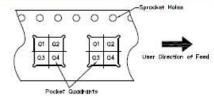


Note: For the most current drawing please refer to website at http://www.irf.com/packaging

# PQFN 5x6 Tape and Reel



#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

Paakage Type	Reel Diameter (Inch)	SIY	Reel Wioth WI (mm)	Aa (mm)	Ba (mm)	Ka (mm)	P1 (mm)	(mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	ଭୀ

Note: For the most current drawing please refer to website at http://www.irf.com/packaging



#### **Qualification Information**

Qualification level	Industrial (per JEDEC JESD47F <sup>†</sup> guidelines )				
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D <sup>†)</sup>			
RoHS Compliant	Yes				

† Applicable version of JEDEC standard at the time of product release.

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25$ °C, L = 0.337mH,  $R_G = 25\Omega$ ,  $I_{AS} = 50$ A.
- 4 R<sub>0</sub> is measured at T<sub>J</sub> of approximately 90°C.
- When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material. Please refer to AN-994 for more details: <a href="http://www.irf.com/technical-info/appnotes/an-994.pdf">http://www.irf.com/technical-info/appnotes/an-994.pdf</a>
- ® Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 9. De-rating will be required based on the actual environmental conditions.

#### **Revision History**

Date	Rev.	Comments			
7/7/2014	2.1	<ul> <li>Updated ordering information to reflect the End-Of-Life (EOL) of the mini-reel option (EOL notice #259).</li> <li>Updated package outline on page 7.</li> <li>Updated data sheet with the new IR corporate template.</li> </ul>			
4/28/2015	2.2	<ul> <li>Updated package outline for "option B" and added package outline for "option G" on page 7</li> <li>Updated tape and reel on page 8.</li> </ul>			
5/19/2015	2.3	<ul> <li>Updated package outline for "option G" on page 7.</li> <li>Updated "IFX logo" on page 1 and page 9.</li> </ul>			
01/29/2021	2.4	<ul> <li>Updated datasheet based on IFX template.</li> <li>Updated Datasheet based on new current rating and application note:         App-AN_1912_PL51_2001_180356     </li> <li>Removed "HEXFET® Power MOSFET" added "IR MOSFET™ "-page1</li> </ul>			



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Edition 2016-04-16 Published by Infineon Technologies AG 81726 Munich, Germany

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